

Description

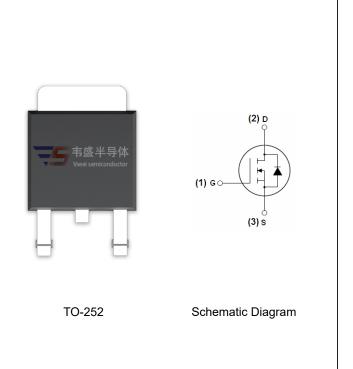
The VSM95N08 uses advanced trench technology and design to provide excellent $R_{DS(ON)}$ with low gate charge. This device is suitable for use in PWM, load switching and general purpose applications.

General Features

- $V_{DS} = 82V, I_D = 95A$ $R_{DS(ON)} < 8.0 \text{ m}\Omega @ V_{GS} = 10V$ (Typ:6.6mΩ)
- High density cell design for ultra low Rdson
- Fully characterized avalanche voltage and current
- Special designed for convertors and power controls
- Good stability and uniformity with high E_{AS}
- Excellent package for good heat dissipation
- Special process technology for high ESD capability

Application

- Power switching application
- Hard switched and High frequency circuits
- Uninterruptible power supply



Package Marking and Ordering Information

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
VSM95N08-T2	VSM95N08	TO-252	-	-	-

Absolute Maximum Ratings (T_A=25℃unless otherwise noted)

Parameter	Symbol	Limit	Unit	
Drain-Source Voltage	V _{DS}	82	V	
Gate-Source Voltage	V _G s	±20	V	
Drain Current-Continuous	I _D	95	А	
Drain Current-Continuous(T _C =100°C)	I _D (100°C)	67	А	
Pulsed Drain Current	I _{DM}	320	А	
Maximum Power Dissipation	P _D	170	W	
Derating factor		1.13	W/℃	
Single pulse avalanche energy (Note 5)	E _{AS}	529	mJ	
Operating Junction and Storage Temperature Range	T_{J}, T_{STG}	-55 To 175	$^{\circ}$	

Thermal Characteristic

Thermal Resistance,Junction-to-Case ^(Note 2)	R _{eJC}	0.88	°C/W
---	------------------	------	------

Shenzhen VSEEI Semiconductor Co., Ltd

Electrical Characteristics (T_A=25°C unless otherwise noted)

Parameter	Symbol	Condition	Min	Тур	Max	Unit
Off Characteristics			•	•		
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V I _D =250µA	82	-	-	V
Zero Gate Voltage Drain Current	Gate Voltage Drain Current I _{DSS} V _{DS} =82V,V _{GS} =0		-	-	1	μA
Gate-Body Leakage Current	I _{GSS}	V _{GS} =±20V,V _{DS} =0V	-	-	±100	nA
On Characteristics (Note 3)				•		
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}$, $I_{D}=250\mu A$	2	2.9	4	V
Drain-Source On-State Resistance	R _{DS(ON)}	V _{GS} =10V, I _D =20A	-	6.6	8.0	mΩ
Forward Transconductance	g FS	V _{DS} =5V,I _D =20A	-	50	-	S
Dynamic Characteristics (Note4)						
Input Capacitance	C _{lss}	\/ -05\/\/ -0\/	-	6800	-	PF
Output Capacitance	Coss	V_{DS} =25V, V_{GS} =0V, F=1.0MHz	-	353	-	PF
Reverse Transfer Capacitance	C _{rss}	Γ-1.UIVIΠZ	-	261	-	PF
Switching Characteristics (Note 4)			•			
Turn-on Delay Time	t _{d(on)}		-	18	-	nS
Turn-on Rise Time	t _r	VDD=40V,RL=15 Ω	-	12	-	nS
Turn-Off Delay Time	t _{d(off)}	RG=2.5Ω,VGS=10V	-	56	-	nS
Turn-Off Fall Time	t _f		-	15	-	nS
Total Gate Charge	Qg	\/ 40\/ L 50A	-	109.3	-	nC
Gate-Source Charge	Q _{gs}	V _{DS} =40V,I _D =50A,	-	35.1	-	nC
Gate-Drain Charge	Q_{gd}	V _{GS} =10V	-	25.8	-	nC
Drain-Source Diode Characteristics	1		•			
Diode Forward Voltage (Note 3)	V _{SD}	V _{GS} =0V,I _S =95A	-	-	1.2	V
Diode Forward Current (Note 2)	Is		-	-	95	Α
Reverse Recovery Time	t _{rr}	Tj=25℃,I _F =100A	-		37	nS
Reverse Recovery Charge	Qrr	di/dt=100A/μs ^(Note3)	-		58	nC

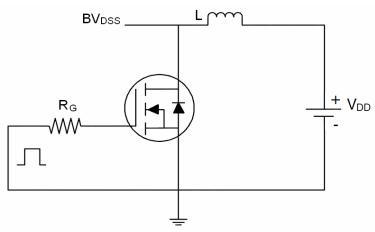
Notes:

- 1. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 2. Surface Mounted on FR4 Board, t ≤ 10 sec.
- 3. Pulse Test: Pulse Width ≤ 300µs, Duty Cycle ≤ 2%.
- **4.** Guaranteed by design, not subject to production
- **5.** EAS condition: Tj=25 $^{\circ}$ C,V_{DD}=40V,V_G=10V,L=0.5mH,Rg=25 Ω

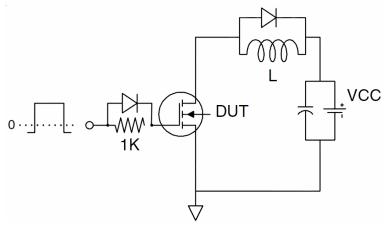


Test Circuit

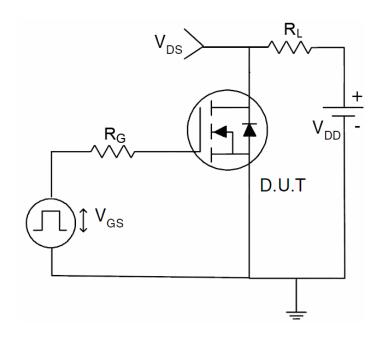
1) E_{AS} Test Circuits



2) Gate Charge Test Circuit



3) Switch Time Test Circuit





Typical Electrical and Thermal Characteristics (Curves

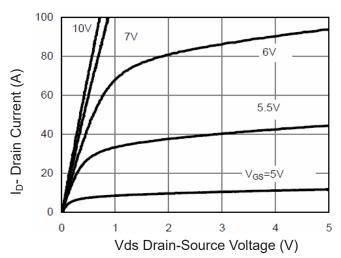


Figure 1 Output Characteristics

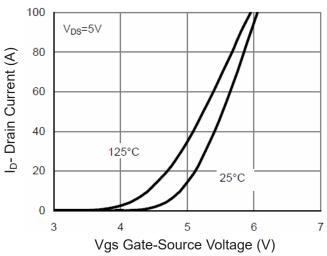


Figure 2 Transfer Characteristics

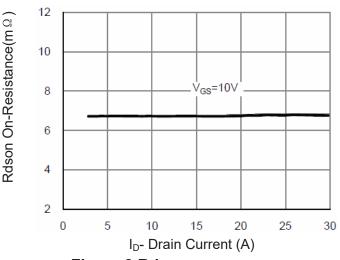


Figure 3 Rdson- Drain Current

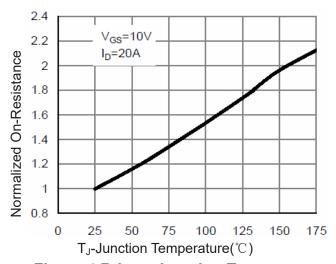
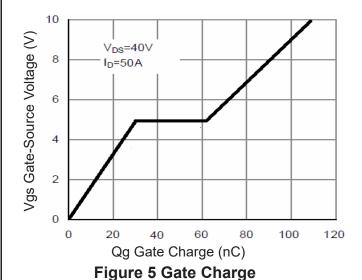


Figure 4 Rdson-Junction Temperature



1.0E+02 (Y) 1.0E+01 1.0E+00 1.0E-01 1.0E-02 1.0E-03 1.0E-04 0.0 0.2 0.4 0.6 0.8 1.0 Vsd Source-Drain Voltage (V)

Figure 6 Source- Drain Diode Forward



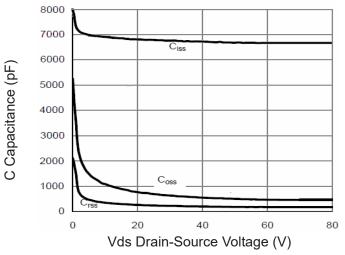


Figure 7 Capacitance vs Vds

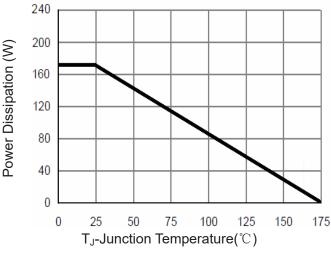


Figure 9 Power De-rating

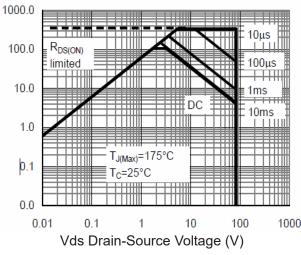


Figure 8 Safe Operation Area

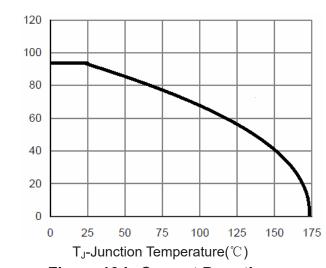
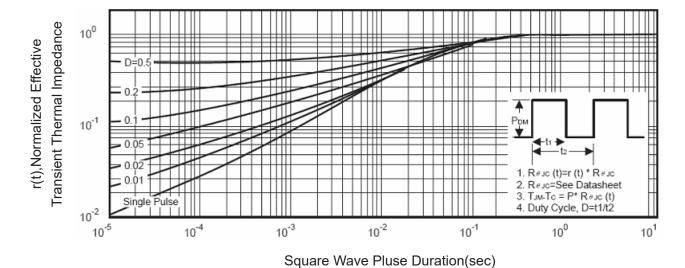


Figure 10 I_D Current De-rating



D- Drain Current (A)

Figure 11 Normalized Maximum Transient Thermal Impedance